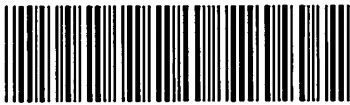


Search Notes

Application/Control No.

10/706,755

Examiner

Stephen W. Smoot

Applicant(s)/Patent under
Reexamination

KIM ET AL.

Art Unit

2813

SEARCHED

Class	Subclass	Date	Examiner
257	75	2/25/2005	SWS
257	347	2/25/2005	SWS
257	503	2/25/2005	SWS
257	506	2/25/2005	SWS
257	524	2/25/2005	SWS

*S.W.S.***INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Key Words: Isolation - Shallow Trench, STI, Field Oxide, FOX;	2/25/2005	<i>S.W.S.</i> SWS
Buried Insulator - Oxide, BOX, Silicon-on-Insulator, SOI; Epitaxial Layer - Silicon.	2/25/2005	<i>S.W.S.</i> SWS
Search Tools - EAST (attached): USPAT; US PG PUBS; Derwent; EPO; JPO; IBM TDB	2/25/2005	<i>S.W.S.</i> SWS